Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/528,754	TANAKA ET AL.		
Examiner	Art Unit		
Tai Duong	2871	_	

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SEARCHED					
Cla	ıss	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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EAST (US PGPUB, USPAT, EPO, JPO, DERWENT, IBM TDB) see search history printout	3/19/2006	TD		
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